


<b>Search Notes</b>  	<b>Application/Control No.</b>  10519753	<b>Applicant(s)/Patent Under Reexamination</b>  KOIKE ET AL.
	<b>Examiner</b>  Chen, Junpeng	<b>Art Unit</b>  2631

SEARCHED			
Class	Subclass	Date	Examiner
455	266,575.7	08/25/2006	J.C.
381	3	08/25/2006	J.C.
367	137	08/25/2006	J.C.
330	9	08/25/2006	J.C.
327	15	08/25/2006	J.C.

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Image and keyword search in USPAT, US-PG Pub, DERWENT, EPO, JPO and IBM_TDB	08/15/2006	J.C.
Consulted with Rafael Perez-Gutierrez, Edan Orgad	08/15/2006	J.C.
Consulted with Fayyaz Alam	01/23/2007	J.C.
Reconsidered the rejection in view of the arguments	3/31/2008	J.C.

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner